Onsemi

MOSFET – P-Channel, POWERTRENCH[®]

-30 V, -20 A, 10 mΩ

FDMC6679AZ

General Description

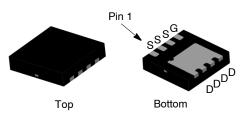
The FDMC6679AZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest r_{DS(on)} and ESD protection.

Features

- Max $r_{DS(on)} = 10 \text{ m}\Omega$ at $V_{GS} = -10 \text{ V}$, $I_D = -11.5 \text{ A}$
- Max $r_{DS(on)} = 18 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -8.5 \text{ A}$
- HBM ESD Protection Level of 8 kV Typical (Note 3)
- Extended V_{GSS} range (-25 V) for Battery Applications
- High Performance Trench Technology for Extremely Low r_{DS(on)}
- High Power and Current Handling Capability
- This Device is Pb–Free and Halide Free

Applications

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management



WDFN8 3.3x3.3, 0.65P CASE 511DH

MARKING DIAGRAM



FDMC6679A	Z = Specific Device Code
А	= Assembly Location

L

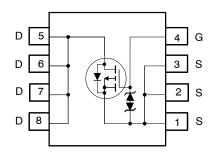
YW

= Assembly Location

= Wafer Lot Number

= Assembly Start Week

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

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MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol		Parameter			
V _{DS}	Drain to Source Voltage		-30	V	
V _{GS}	Gate to Source Voltage			±25	V
ID	Drain Current	Continuous	T _C = 25°C	-20	Α
		Continuous (Note 1a)	T _A = 25°C	-11.5	
		Pulsed		-32	
PD	Power Dissipation		T _C = 25°C	41	W
	Power Dissipation (Note 1a)		T _A = 25°C	2.3	
T _J , T _{STG}	Operating and Storage Junction	Temperature Range	•	–55 to + 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

1. $R_{\theta,JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 53°C/W when mounted on a 1 in² pad of 2 oz copper



b. $125^{\circ}C/W$ when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
OFF CHARA	OFF CHARACTERISTICS							
BV _{DSS}	Drain to Source Breakdown Voltage	I_D = –250 μ A, V _{GS} = 0 V	-30			V		
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C		29		mV/°C		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24$ V, $V_{GS} = 0$ V			-1	μΑ		
		V_{DS} = –24 V, V_{GS} = 0 V, T_J = 125°C			-100			
I _{GSS}	Gate to Source Leakage Current	V_{GS} = ± 25 V, V_{DS} = 0 V			±10	μΑ		

ON CHARACTERISTICS

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS}=V_{DS},\ I_{D}=-250\ \mu A$	-1.0	-1.8	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C		-7		mV/°C
r _{DS(on)}	Static Drain	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -11.5 \text{ A}$		8.6	10	mΩ
	to Source On Resistance	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -8.5 \text{ A}$		12	18	
		V_{GS} = -10 V, I _D = -11.5 A, T _J = 125°C		12	15	
9 FS	Forward Transconductance	V _{DS} = -5 V, I _D = -11.5 A		46		S

DYNAMIC CHARACTERISTICS

ſ	C _{iss}	Input Capacitance	V_{DS} = -15 V, V_{GS} = 0 V, f = 1 MHz	2985	3970	pF
	C _{oss}	Output Capacitance		570	755	pF
	C _{rss}	Reverse Transfer Capacitance		500	750	pF

SWITCHING CHARACTERISTICS

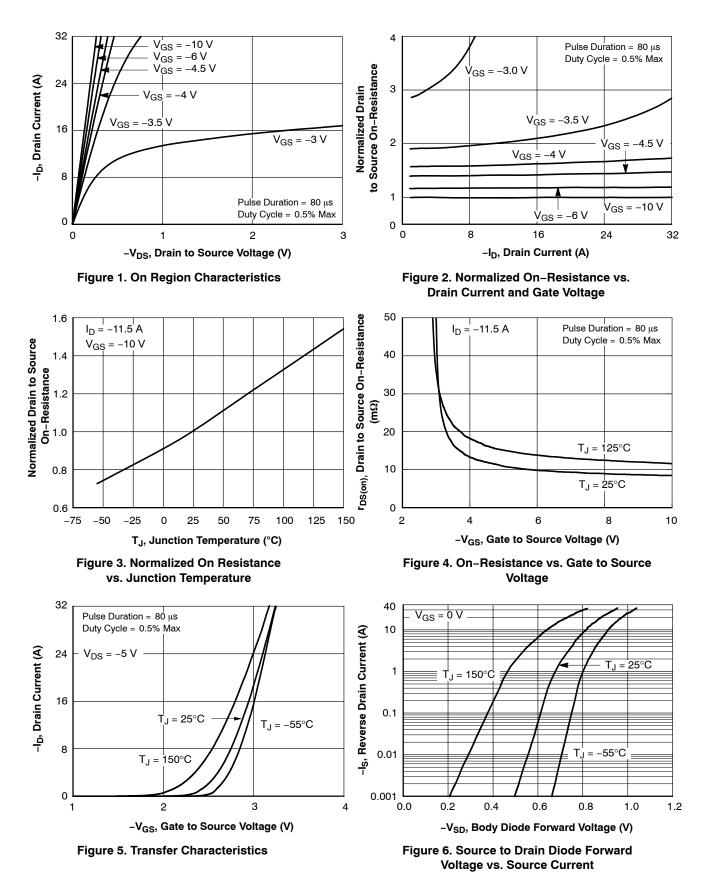
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -15$ V, $I_D = -11.5$ A, $V_{GS} = -10$ V,	12	21	ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$	14	25	ns
t _{d(off)}	Turn-Off Delay Time		63	100	ns
t _f	Fall Time		46	73	ns
Qg	Total Gate Charge	V_{GS} = 0 V to -10 V, V_{DD} = -15 V, I_{D} = -11.5 A	65	91	nC
		V_{GS} = 0 V to -5 V, V_{DD} = -15 V, I_D = -11.5 A	37	52	nC
Q _{gs}	Gate to Source Charge	V _{DD} = -15 V, I _D = -11.5 A	8.7		nC
Q _{gd}	Gate to Drain "Miller" Charge		17		nC

DRAIN-SOURCE DIODE CHARACTERISTICS

V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = -11.5 A$ (Note 2)	0.83	1.30	V
	Voltage	$V_{GS} = 0 V, I_S = -1.6 A$ (Note 2)	0.71	1.20	
t _{rr}	Reverse Recovery Time	$I_F = -11.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	31	49	ns
Q _{rr}	Reverse Recovery Charge		16	28	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)



TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

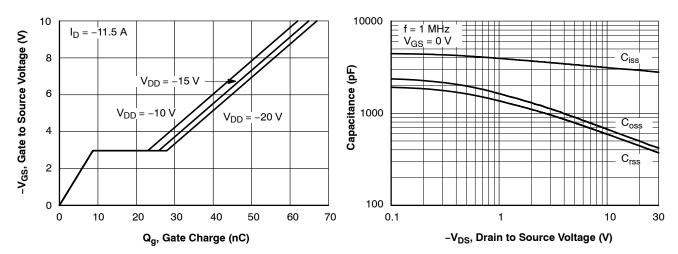
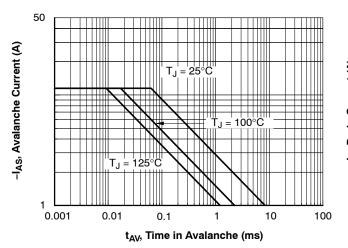
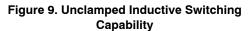


Figure 7. Gate Charge Characteristics





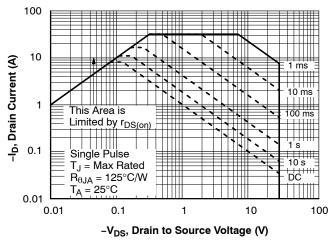




Figure 8. Capacitance vs. Drain to Source Voltage

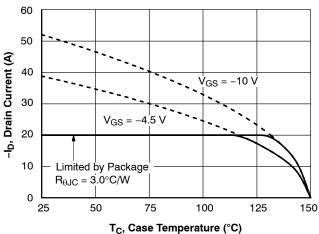
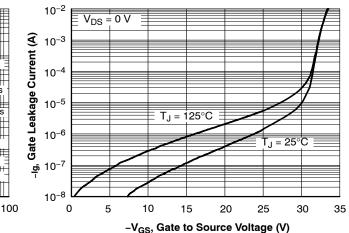
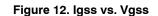
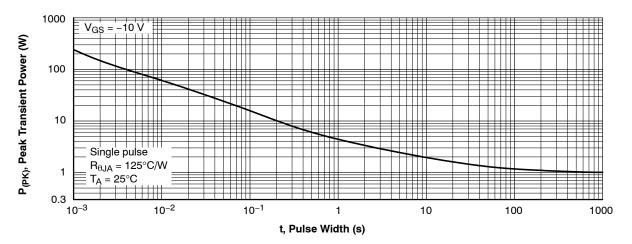


Figure 10. Maximum Continuous Drain Current vs Case Temperature





TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)





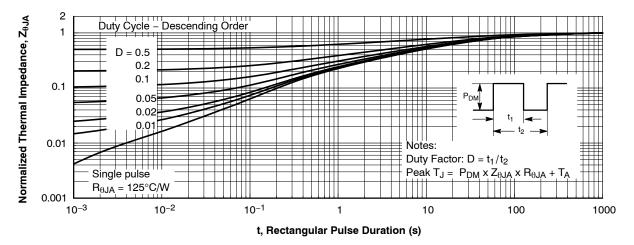


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

ORDERING INFORMATION

Device	Device Marking	Package Type	Shipping [†]
FDMC6679AZ	FDMC6679AZ	WDFN8 3.3x3.3, 0.65P, Case 511DH (Pb-Free)	3000 / Tape & Reel

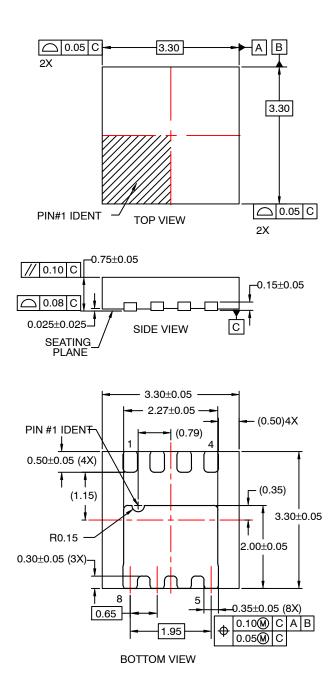
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

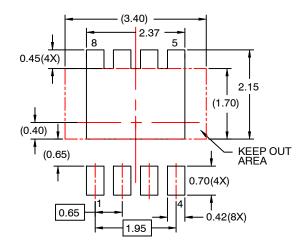
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WDFN8 3.3x3.3, 0.65P CASE 511DH ISSUE O

DATE 31 JUL 2016





RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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